

Advanced Power MOSFET

IRFS640A

FEATURES

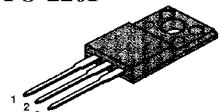
- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 10 μ A (Max.) @ V_{DS} = 200V
- Lower R_{DS(on)} : 0.144 Ω (Typ.)

BV_{DSS} = 200 V

R_{DS(on)} = 0.18 Ω

I_D = 9.8 A

TO-220F



1.Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V _{DSS}	Drain-to-Source Voltage	200	V
I _D	Continuous Drain Current (T _C =25 °C)	9.8	A
	Continuous Drain Current (T _C =100 °C)	6.2	
I _{DM}	Drain Current-Pulsed ①	72	A
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulsed Avalanche Energy ②	256	mJ
I _{AR}	Avalanche Current ①	9.8	A
E _{AR}	Repetitive Avalanche Energy ①	4.3	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
P _D	Total Power Dissipation (T _C =25 °C)	43	W
	Linear Derating Factor	0.35	W/°C
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
R _{θJC}	Junction-to-Case	--	2.89	°C/W
R _{θJA}	Junction-to-Ambient	--	62.5	

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Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	200	--	--	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.26	--	$^\circ\text{C}$	$\text{I}_D=250\mu\text{A}$ See Fig 7
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	2.0	--	4.0	V	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=250\mu\text{A}$
I_{GSS}	Gate-Source Leakage , Forward	--	--	100	nA	$\text{V}_{\text{GS}}=30\text{V}$
	Gate-Source Leakage , Reverse	--	--	-100		$\text{V}_{\text{GS}}=-30\text{V}$
I_{DSS}	Drain-to-Source Leakage Current	--	--	10	μA	$\text{V}_{\text{DS}}=200\text{V}$
		--	--	100		$\text{V}_{\text{DS}}=160\text{V}, \text{T}_C=125^\circ\text{C}$
$\text{R}_{\text{DS(on)}}$	Static Drain-Source On-State Resistance	--	--	0.18	Ω	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=4.9\text{A}$ ④
g_{fs}	Forward Transconductance	--	8.4	--	Ω	$\text{V}_{\text{DS}}=40\text{V}, \text{I}_D=4.9\text{A}$ ④
C_{iss}	Input Capacitance	--	1160	1500	pF	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	--	210	250		
C_{rss}	Reverse Transfer Capacitance	--	94	110		
$t_{\text{d(on)}}$	Turn-On Delay Time	--	17	40	ns	$\text{V}_{\text{DD}}=100\text{V}, \text{I}_D=18\text{A}, \text{R}_G=9.1\Omega$ See Fig 13 ④ ⑤
t_r	Rise Time	--	16	40		
$t_{\text{d(off)}}$	Turn-Off Delay Time	--	48	110		
t_f	Fall Time	--	24	60		
Q_g	Total Gate Charge	--	44	58	nC	$\text{V}_{\text{DS}}=160\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{I}_D=18\text{A}$ See Fig 6 & Fig 12 ④ ⑤
Q_{gs}	Gate-Source Charge	--	10.4	--		
Q_{gd}	Gate-Drain("Miller") Charge	--	27.1	--		

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_S	Continuous Source Current	--	--	9.8	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	--	--	72		
V_{SD}	Diode Forward Voltage ④	--	--	1.5	V	$\text{T}_J=25^\circ\text{C}, \text{I}_S=9.8\text{A}, \text{V}_{\text{GS}}=0\text{V}$
t_{rr}	Reverse Recovery Time	--	195	--	ns	$\text{T}_J=25^\circ\text{C}, \text{I}_F=18\text{A}$
Q_{rr}	Reverse Recovery Charge	--	1.35	--	μC	$d\text{I}_F/dt=100\text{A}/\mu\text{s}$ ④

Notes :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② $L=4\text{mH}, \text{I}_{AS}=9.8\text{A}, \text{V}_{DD}=50\text{V}, \text{R}_G=2\Omega, \text{Starting } T_J=25^\circ\text{C}$
- ③ $\text{I}_{SD} \leq 18\text{A}, d\text{I}/dt \leq 260\text{A}/\mu\text{s}, \text{V}_{DD} \leq \text{BV}_{DSS}$, Starting $T_J=25^\circ\text{C}$
- ④ Pulse Test : Pulse Width = $250\mu\text{s}$, Duty Cycle $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature

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Fig 1. Output Characteristics

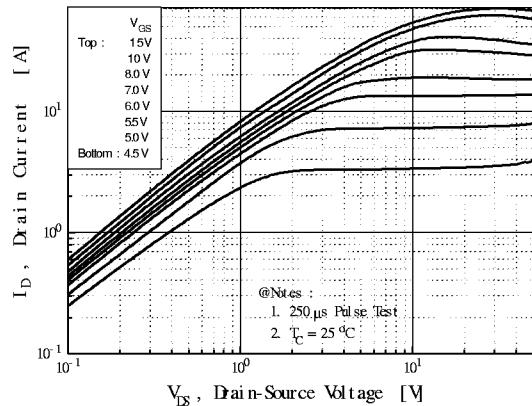


Fig 2. Transfer Characteristics

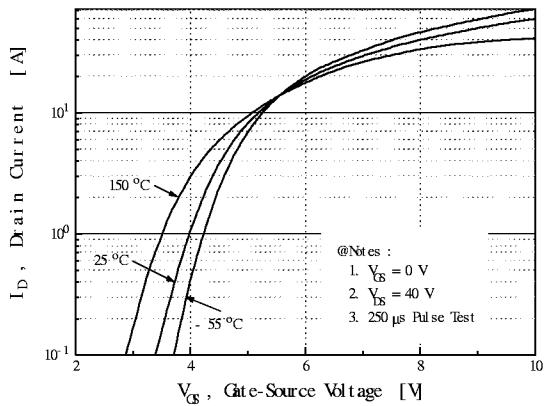


Fig 3. On-Resistance vs. Drain Current

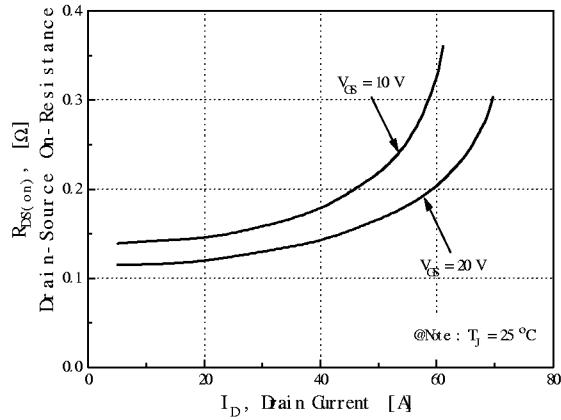


Fig 4. Source-Drain Diode Forward Voltage

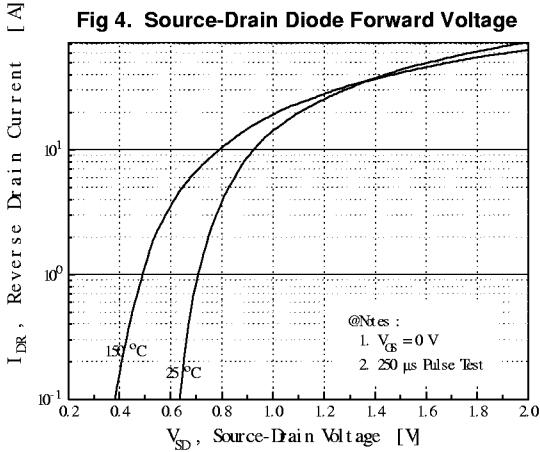


Fig 5. Capacitance vs. Drain-Source Voltage

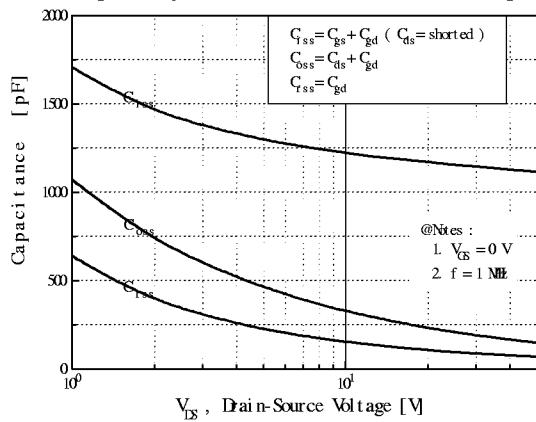
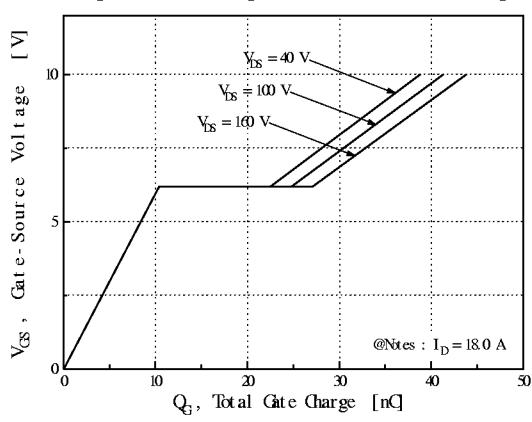
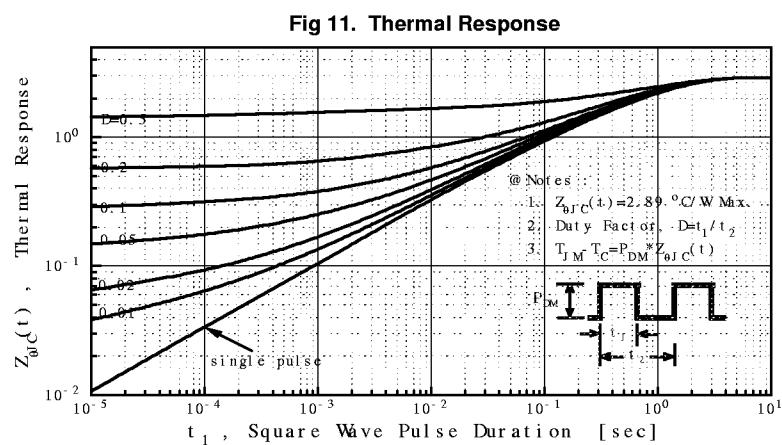
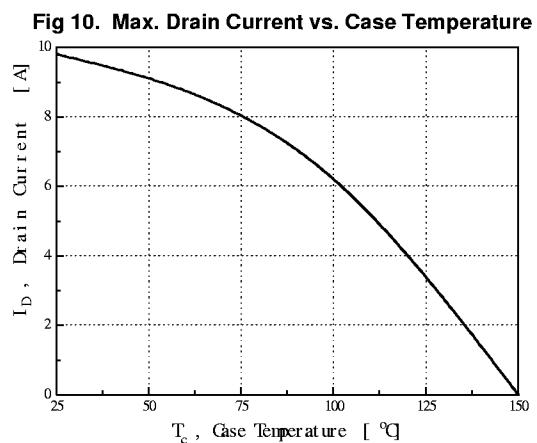
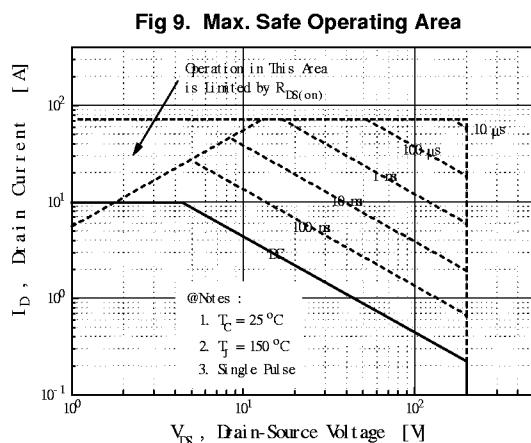
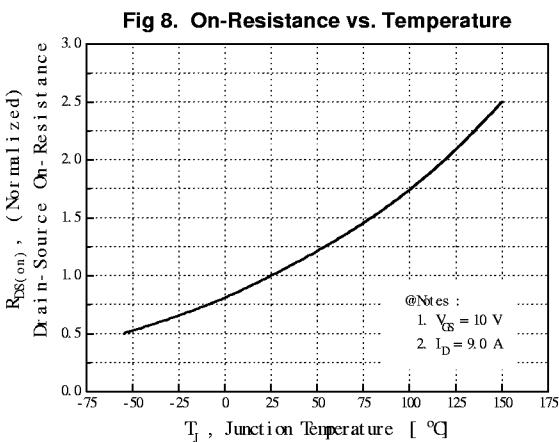
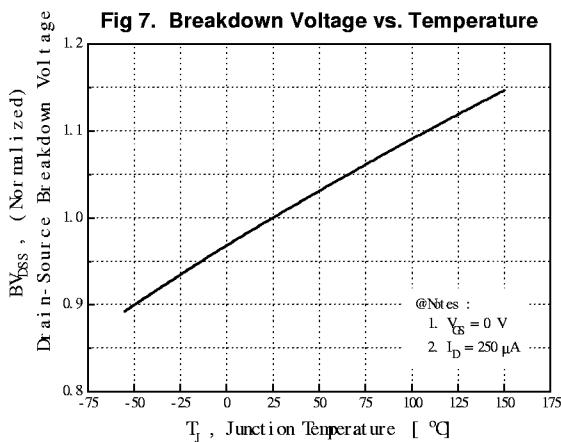


Fig 6. Gate Charge vs. Gate-Source Voltage



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Fig 12. Gate Charge Test Circuit & Waveform

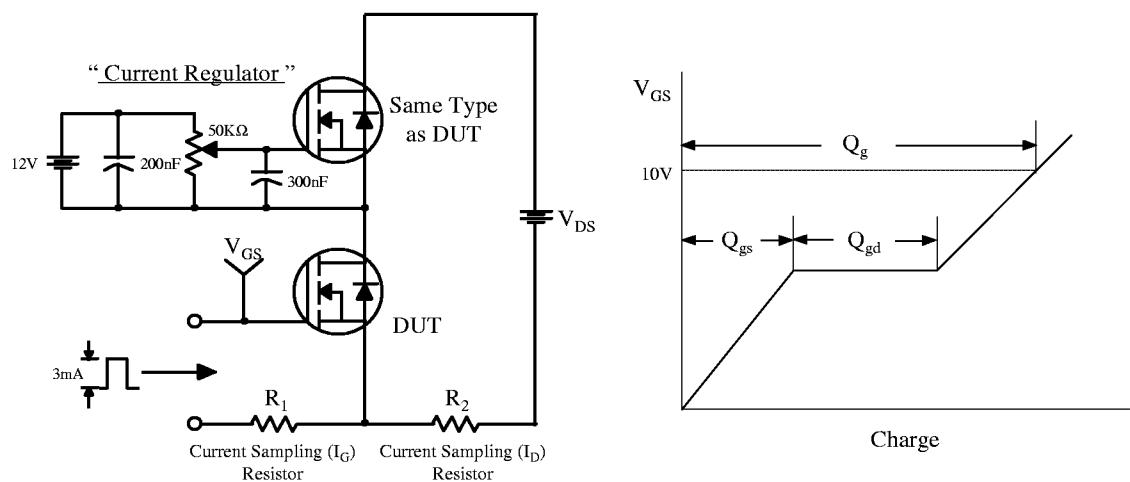


Fig 13. Resistive Switching Test Circuit & Waveforms

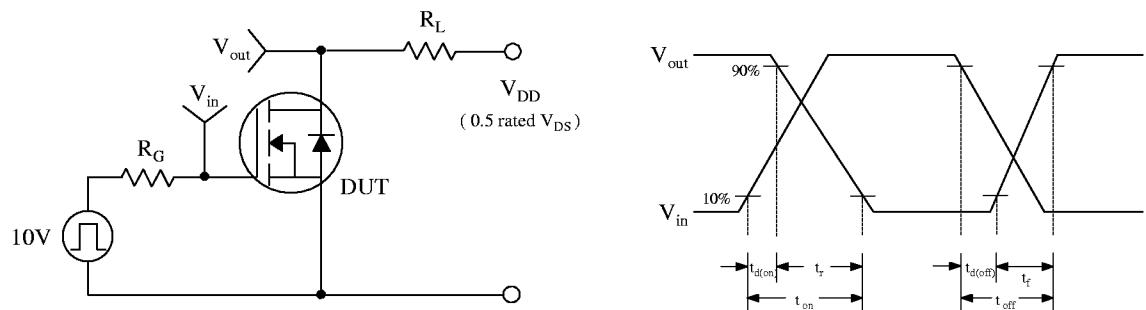
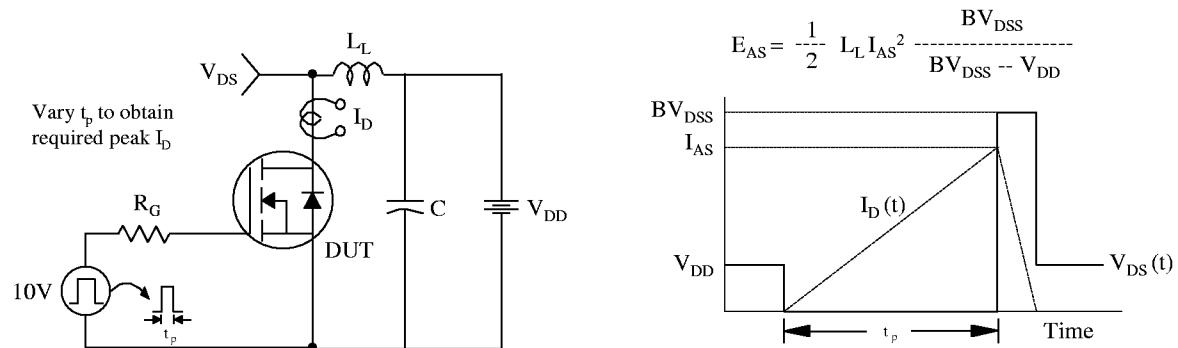


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

